TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII)

# 2SK2608

### **Switching Regulator Applications**

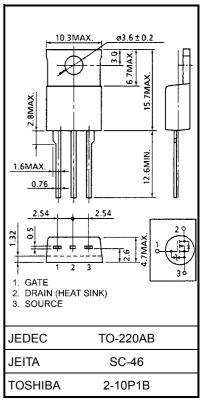
Unit: mm

Low drain-source ON resistance : RDS (ON) = 3.73 Ω (typ.)
 High forward transfer admittance : |Yfs| = 2.6 S (typ.)

 $\begin{array}{ll} \bullet & Low \ leakage \ current \\ \bullet & Enhancement-mode \end{array} & \vdots \ I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 720 \ V) \\ \vdots \ V_{th} = 2.0 {\sim} 4.0 \ V \ (V_{DS} = 10 \ V, \ I_D = 1 \ mA) \\ \end{array}$ 

### Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	900	V	
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		$V_{DGR}$	900	V	
Gate-source voltage		$V_{GSS}$	±30	V	
Drain current	DC (Note 1)	I <sub>D</sub>	3	Α	
	Pulse (Note 1)	I <sub>DP</sub>	9	Α	
Drain power dissipation	n (Tc = 25°C)	$P_{D}$	100	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	295	mJ	
Avalanche current		I <sub>AR</sub>	3	Α	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	10.0	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	



Weight: 2.0 g (typ.)

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	1.25	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	83.3	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

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Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 60.0 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = 3 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device.

Please handle with caution.

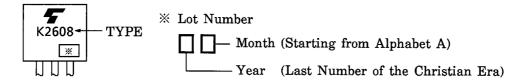
## **Electrical Characteristics (Ta = 25°C)**

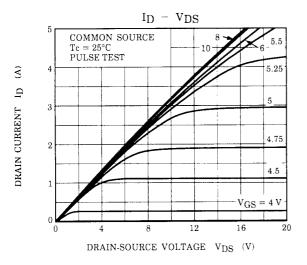
Charac	eteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I <sub>G</sub> = ±10 μA, V <sub>DS</sub> = 0 V	±30	_	_	V
Drain cut-off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 720 V, V <sub>GS</sub> = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	$I_D$ = 10 mA, $V_{GS}$ = 0 V	900	_	_	V
Gate threshold v	oltage	$V_{th}$	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.5 A	_	3.73	4.3	Ω
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 1.5 A	0.65	2.6	_	S
Input capacitano	e	C <sub>iss</sub>		_	750	_	
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	10	_	pF
Output capacitance		C <sub>oss</sub>		_	70	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS}^{10V}$ $V_{GS}^{10V}$ $R_{L}=133\Omega$	_	15	_	- ns
	Turn-on time	t <sub>on</sub>		_	55	_	
	Fall time	t <sub>f</sub>		_	30	_	
	Turn-off time	t <sub>off</sub>	$V_{DD} \stackrel{.}{=} 200V$ Duty $\leq 1\%$ , $t_w = 10 \mu s$	_	110	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	25	_	
Gate-source charge		$Q_{gs}$	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$		13	_	nC
Gate-drain ("miller") Charge		$Q_{gd}$			12	_	

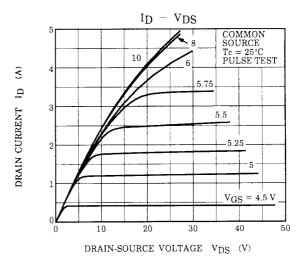
# Source-Drain Ratings and Characteristics (Ta = 25°C)

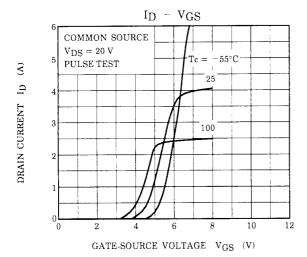
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	3	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	9	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 3 A, V <sub>GS</sub> = 0 V	_	_	-1.9	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 3 A, V <sub>GS</sub> = 0 V, dI <sub>DR</sub> / dt = 100 A / μs	1	1200		ns
Reverse recovery charge	Q <sub>rr</sub>	1DR - 3 Λ, VGS - 0 V, αIDR / αι - 100 Α / μs		8.5	_	μC

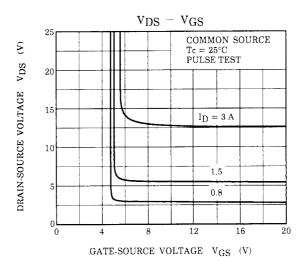
## Marking

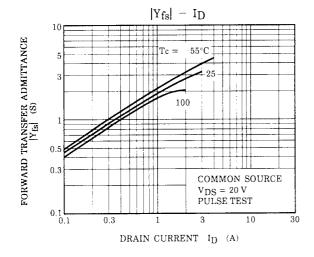


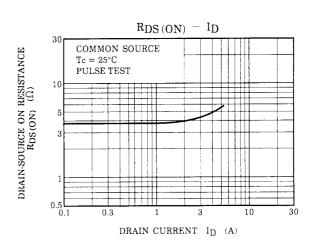




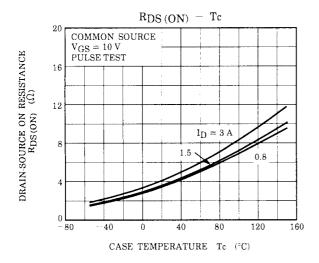


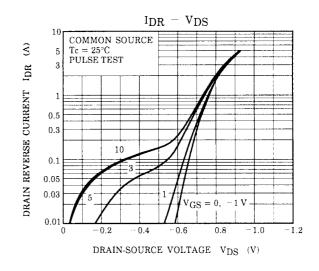


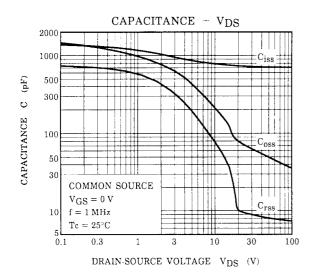


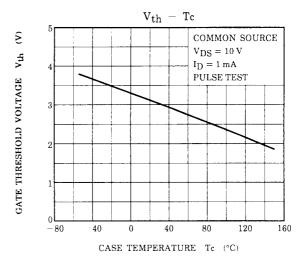


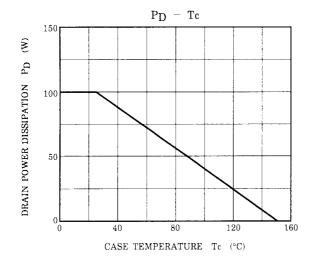
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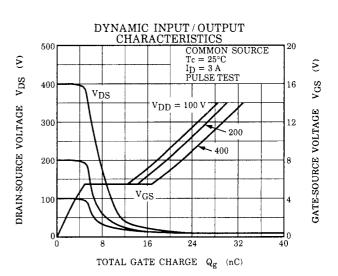




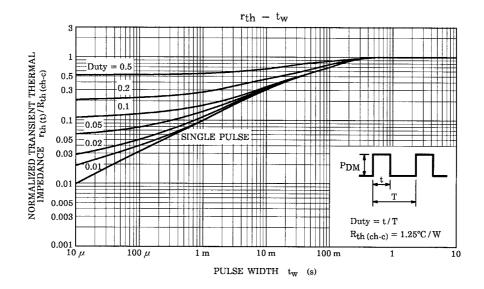


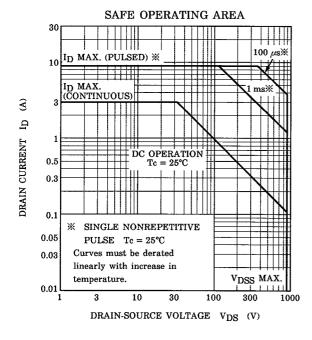


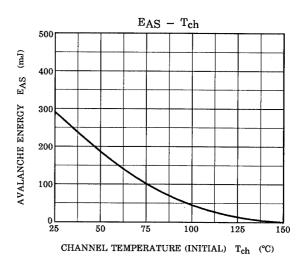


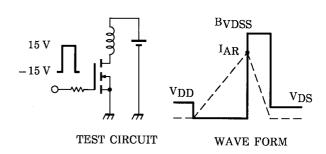


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$$R_G = 25 \Omega$$
  
 $V_{DD} = 90 \text{ V}, L = 60 \text{ mH}$   $E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}}\right)$ 

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